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-100V P-Channe Enhancement Mode Power MOSFET



Description

The XPX10P08RD uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

V_{DS} = -100V I_D =-80A

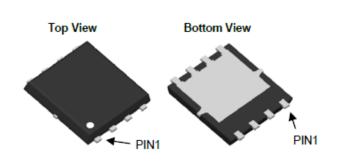
 $R_{DS(ON)}$ <18m Ω @ V_{GS}=10V

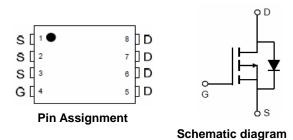
Application

Brushless motor

Load switch

Uninterruptible power supply





Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)				
XPX10P08RD	PDFN5*6-8L	XPX10P08RD XXX YYYY	5000				
Absolute Maximum Ratings (T _c =25 [°] C unless otherwise noted)							
Symbol	Parameter	Rating	Units				
Vds	Drain-Source Voltage	-100	V				
Vgs	Gate-Source Voltage	±20	V				
I₀@Tc=25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-80	А				
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-56	А				
Ідм	Pulsed Drain Current ²	-300	А				
EAS	Single Pulse Avalanche Energy ³	174	mJ				
las	Avalanche Current	-50	А				
P _D @T _C =25°C	Total Power Dissipation ⁴	280	W				
Тѕтс	Storage Temperature Range	-55 to 150	°C				
TJ	Operating Junction Temperature Range	-55 to 150	°C				
R _θ JA	Thermal Resistance Junction-Ambient ¹	25	°C/W				
Rejc	Thermal Resistance Junction-Case ¹	0.65	°C/W				



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P-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250µA	-100	110	-	V
IDSS	Zero Gate Voltage Drain Current	V _{DS} =-100V, V _{GS} =0V,	-	-	-1.0	μA
IGSS	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±20V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250µA	-1.0	-1.6	-2.5	V
RDS(on)	Static Drain-Source on-Resistance	V _{GS} =-10V, I _D =-20A	-	18	25	
		V _{GS} =-4.5V, I _D =-10A	-	21	30	mΩ
Ciss	Input Capacitance		-	4228	-	pF
Coss	Output Capacitance	V _{DS} =-50V, V _{GS} =0V, f=1.0MHz	-	388	-	pF
Crss	Reverse Transfer Capacitance	1 1.00012	-	27	-	pF
Qg	Total Gate Charge		-	80	-	nC
Qgs	Gate-Source Charge	V _{DS} =-50V, I _D =-5A, V _{GS} =-10V	-	15.6	-	nC
Qgd	Gate-Drain("Miller") Charge	V8310V	-	17.2	-	nC
td(on)	Turn-on Delay Time		-	26	-	ns
tr	Turn-on Rise Time	V _{DD} =-50V, I _D =-5A,	-	78	-	ns
td(off)	Turn-off Delay Time	R _G =6Ω, V _{GS} =-10V	-	200	-	ns
t _f	Turn-off Fall Time		-	210	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	-80	А
ISM	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-280	А
VSD	Drain to Source Diode Forward Voltage	V _{GS} =0V, I _S =-30A	-	-	-1.2	V
trr	Body Diode Reverse Recovery Time	Tյ=25℃,	-	208	-	ns
Q _{rr}	Body Diode Reverse Recovery Charge	l⊧=-5A,dI/dt=100A/µs	-	560	-	nC

Note :

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

2、The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

3、The EAS data shows Max. rating . The test condition is V DD =-72V,VGS =-10V,L=0.1mH,IAS =-50A

4. The power dissipation is limited by 150 $^\circ\!\!\mathbb{C}$ junction temperature

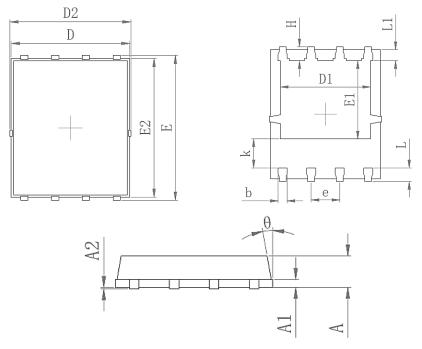
5. The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.



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Package Mechanical Data-PDFN5X6-8L-XZT Single



	Common mm			
Symbol				
	Mim	Max		
A	0.90	1.10		
A1	0.254	0.254 REF		
A2	0-0	0-0.05		
D	4.824	4.976		
D1	3.910	4.110		
D2	4.944	5.076		
E	5.924	6.076		
E1	3.375	3.575		
E2	5.674	5.826		
b	0.350	0.450		
е	1.2	1.270		
L	0.534	0.686		
L1	0.424	0.576		
К	1.190	1.390		
Н	0.549	0.701		
Φ	8 °	12°		



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Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb device	245℃±5 ℃	5sec±1sec
Pb-Free device	260 ℃+0/-5℃	5sec±1sec



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